## Notice of References Cited Application/Control No. 10/603,726 Examiner TuyetLien (Lien) T. Tran Applicant(s)/Patent Under Reexamination HENRY ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,901,555 B2	05-2005	Hida et al.	715/734
*	В	US-6,421,509 b1	07-2002	Nomura et al.	399/81
*	C	US-2003/0197896 A1	10-2003	Doyle, Brian P.	358/1.18
*	۵	US-6,470,383 b1	10-2002	Leshem et al.	709/223
*	Е	US-6,978,472 b1	12-2005	Nashida et al.	725/52
*	F	US-6,628,313 b1	09-2003	Minakuchi et al.	715/853
*	G	US-5,977,974	11-1999	Hatori et al.	715/839
	Н	US-			
	1	US-		·	
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	R					
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## **NON-PATENT DOCUMENTS**

	NOTE ATEN DOGINERTO								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.